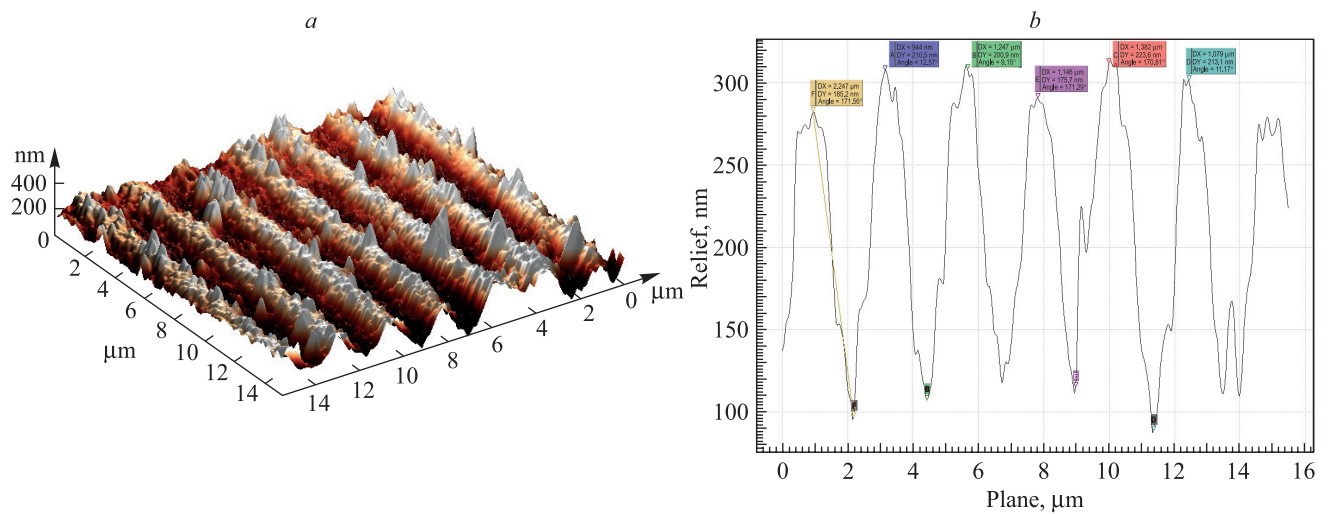


Fig. 6. Surface morphology of a sample after the etching process (AFM):
a – surface morphology of the exposed sample 3D; *b* – surface structure profile